

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Waitl et al.

Art Unit : 2891

Serial No.

10/723,928

Examiner : David Zarneke

Filed

: November 26, 2003

Title

: TWO-POLE SMT MINIATURE HOUSING FOR SEMICONDUCTOR COMPONENTS

AND METHOD FOR THE MANUFACTURE THEREOF

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Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This statement is being filed after a Notice of Allowance, but before payment of the issue fee. A check for \$180 in payment of the late submission fee of \$1.17(p) is enclosed. Please apply any other charges or credits to Deposit Account No. 06-1050, referencing 12406-081003.

Respectfully submitted,

Marc M. Wefers Reg. No. 56,842

Fish & Richardson P.C. 225 Franklin Street Boston, MA 02110

Telephone: (617) 542-5070 Facsimile: (617) 542-8906

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Sheet	1	of	4

Stratitute 50 PTO-1449

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 12406-081003

Application No. 10/723,928

Information Disclosure Statement by Applicant (Use several sheets if necessary) Applicant Waitl et al.

Filing Date

Group Art Unit 2891

(37 CFR §1.98(b))

November 26, 2003

	U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate	
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	AB	3,573,568	04/1971	Harvey V. Siegel				
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	AE	3,976,877	08/1976	Thillays		***		
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Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12406-081003	Application No. 10/723,928	
	closure Statement oplicant	Applicant Waitl et al.		
(Use several sh	eets if necessary)	Filing Date	Group Art Unit	
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	Foreign Patent Documents or Published Foreign Patent Applications							
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Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
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	CA	2347289	04/18/1974	Germany			Abstract,	
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			ļ				3,774,086	
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				1	+		Only	
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	CT	61 249920	11/06/1006	T			Abstract	
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	Foreign Patent Documents or Published Foreign Patent Applications							
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Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
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	DB	98/20718	05/14/1998	WIPO			Abstract Only	
	DC							
	DD							

	Other D	ocuments (include Author, Title, Date, and Place of Publication)
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Initial	ID	Document
	DE	
	DF	

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